Express Mailing Label No. EL899800902US

PATENT

No. P0164US-7

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants:

Parikh et al.

Examiner: Shouxiang Hu

Serial No.

09/911,155

Art Unit: 2811

Filing Date:

July 23, 2001

GALLIUM NITRIDE BASED DIODES WITH LOW FORWARD VOLTAGE

AND LOW REVERSE CURRENT OPERATION

Assistant Commissioner for Patents

Washington, D.C. 20231

AMENDMENT TRANSMITTAL

Sir:

Transmitted herewith is an amendment for this application. Applicant is a large entity.

Fee for Claims

| | Claims Remaining After Amendment | Highest No. Previously Paid For | Present Extra | Rate | Addit. Fee |
|---------|---|---------------------------------------|------------------|-------|---------------|
| TOTAL | 57 | 51 | 6 | 18.00 | 108.00 |
| INDEP. | 4 | 4 | 0 | 84.00 | 0.00 |
| Total - | | | | | \$108.00 |

Enclosed is our check No. 184640ur Docket No. H110037US9 in the amount of \$108 reflecting the fee for the additional six claims. If any additional fee is required, charge Deposit Account No. 11-1580. A duplicate of this transmittal is attached.

Respectfully submitted,

June 27, 2002

e G. Hevbl

Registration No.42,661

Attorney for Applicant

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M/J3-P0164US7amend trans

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Express Mail Label No. EL89980

P0164US7

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Parikh et al.

Serial No.: 09/911,155

Examiner: Shouxiang Hu

Filed: July 23, 2001

Art Unit: 2811

Title: GALLIUM NITRIDE BASED DIODES **FORWARD** WITH LOW

VOLTAGE AND LOW REVERSE CURRENT OPERATION

Assistant Commissioner for Patents Washington, D.C. 20231

Sir:

AGE AND LOW REVERSE CURRENT OPERATION

Stant Commissioner for Patents
ington, D.C. 20231

AMENDMENT AND RESPONSE TO OFFICE ACTION

In response to the Office Action dated March 27, \$2002, kindly amend the above application as follows:

Claims

corresponding the claims in the original application with the following amended claims:

A group III nitride based diode, comprising:

an n+ doped GaN layer;

an n-doped GaN layer on said n+ GaN layer;

a Schottky metal layer on said n- doped GaN layer having a work function, said n- GaN layer forming a junction with said Schottky metal, said junction having a barrier potential energy level that is dependent upon the work function of said Schottky metal; and

a trench structure on the surface of said n- layer, said diode experiencing a reverse leakage current under reverse bias, said trench structure reducing the amount of reverse leakage current.

The diode of claim 1, wherein said barrier potential

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